Low-Voltage 1.8/2.5/3.3V 16-Bit Buffer

With 3.6 V-Tolerant Inputs and Outputs (3-State, Inverting)

The 74VCX16240 is an advanced performance, inverting 16-bit buffer. It is designed for very high-speed, very low-power operation in 1.8 V, 2.5 V or 3.3 V systems.

When operating at 2.5 V (or 1.8 V) the part is designed to tolerate voltages it may encounter on either inputs or outputs when interfacing to 3.3 V busses. It is guaranteed to be over–voltage tolerant to 3.6 V.

The 74VCX16240 is nibble controlled with each nibble functioning identically, but independently. The control pins may be tied together to obtain full 16-bit operation. The 3-state outputs are controlled by an Output Enable (\overline{OEn}) input for each nibble. When \overline{OEn} is LOW, the outputs are on. When \overline{OEn} is HIGH, the outputs are in the high impedance state.

Features

- Designed for Low Voltage Operation: $V_{CC} = 1.65 \text{ V} 3.6 \text{ V}$
- 3.6V Tolerant Inputs and Outputs
- High Speed Operation: 2.5 ns max for 3.0 V to 3.6 V

3.0 ns max for 2.3 V to 2.7 V

6.0 ns max for 1.65 V to 1.95 V

• Static Drive: ±24 mA Drive at 3.0 V

±18 mA Drive at 2.3 V ±6 mA Drive at 1.65 V

- Supports Live Insertion and Withdrawal
- I_{OFF} Specification Guarantees High Impedance When $V_{CC} = 0 \text{ V}$
- Near Zero Static Supply Current in All Three Logic States (20 μA)
 Substantially Reduces System Power Requirements
- Latchup Performance Exceeds ±250 mA @ 125°C
- ESD Performance: Human Body Model >2000 V;

Machine Model >200 V

• All Devices in Package TSSOP are Inherently Pb-Free*



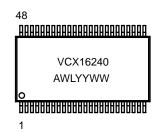
ON Semiconductor®

http://onsemi.com

MARKING DIAGRAM



TSSOP-48 DT SUFFIX CASE 1201



A = Assembly Location

WL = Wafer Lot YY = Year WW = Work Week

ORDERING INFORMATION

| Device | Package | Shipping [†] |
|---------------|--------------------|-----------------------|
| 74VCX16240DT | TSSOP (Pb-Free) | 39 / Rail |
| 74VCX16240DTR | TSSOP (Pb-Free) | 2500 / Reel |

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

^{*}For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

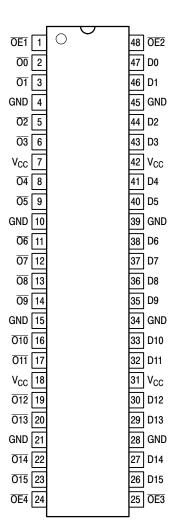


Figure 1. 48-Lead Pinout (Top View)

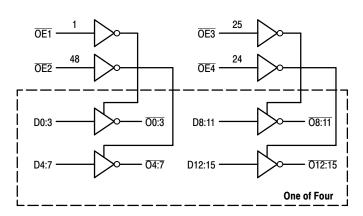


Figure 2. Logic Diagram

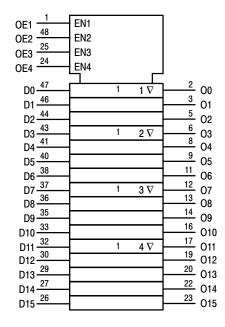


Figure 3. IEC Logic Diagram

Table 1. PIN NAMES

| Pins | Function |
|--------|----------------------|
| OEn | Output Enable Inputs |
| D0-D15 | Inputs |
| O0-O15 | Outputs |

TRUTH TABLE

| OE1 | D0:3 | O0:3 | OE2 | D4:7 | 04:7 | OE3 | D8:11 | O8:11 | OE4 | D12:15 | O12:15 |
|-----|------|------|-----|------|------|-----|-------|-------|-----|--------|--------|
| L | L | Н | L | L | Н | L | L | Н | L | L | Н |
| L | Н | L | L | Н | L | L | Н | L | L | Н | L |
| Н | Χ | Z | Н | Х | Z | Н | Χ | Z | Н | Х | Z |

H = High Voltage Level;

L = Low Voltage Level;

Z = High Impedance State;

X = High or Low Voltage Level and Transitions Are Acceptable, for I_{CC} reasons, DO NOT FLOAT Inputs

ABSOLUTE MAXIMUM RATINGS

| Symbol | Parameter | Value | Condition | Unit |
|------------------|----------------------------------|-----------------------------------|----------------------------------|------|
| V _{CC} | DC Supply Voltage | -0.5 to +4.6 | | V |
| VI | DC Input Voltage | $-0.5 \le V_1 \le +4.6$ | | V |
| Vo | DC Output Voltage | $-0.5 \le V_O \le +4.6$ | Output in 3-State | V |
| | | $-0.5 \le V_{O} \le V_{CC} + 0.5$ | Note 1; Outputs Active | V |
| I _{IK} | DC Input Diode Current | -50 | V _I < GND | mA |
| I _{OK} | DC Output Diode Current | -50 | V _O < GND | mA |
| | | +50 | V _O > V _{CC} | mA |
| Io | DC Output Source/Sink Current | ±50 | | mA |
| I _{CC} | DC Supply Current Per Supply Pin | ±100 | | mA |
| I _{GND} | DC Ground Current Per Ground Pin | ±100 | | mA |
| T _{STG} | Storage Temperature Range | -65 to +150 | | °C |

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

1. I_O absolute maximum rating must be observed.

RECOMMENDED OPERATING CONDITIONS

| Symbol | Parameter | | Min | Тур | Max | Unit |
|-----------------|--|-----------------------|-------------|------------|------------------------|------|
| V _{CC} | Supply Voltage Data Ret | Operating ention Only | 1.65 1.2 | 3.3 3.3 | 3.6 3.6 | V |
| VI | Input Voltage | | -0.3 | | 3.6 | V |
| Vo | Output Voltage (Active State) (3–State) | | 0 0 | | V _{CC} 3.6 | V |
| I _{OH} | HIGH Level Output Current, V _{CC} = 3.0 V - 3.6 V | | | | -24 | mA |
| I _{OL} | LOW Level Output Current, V _{CC} = 3.0 V – 3.6 V | | | | 24 | mA |
| I _{OH} | HIGH Level Output Current, V _{CC} = 2.3 V - 2.7 V | | | | -18 | mA |
| I _{OL} | LOW Level Output Current, V _{CC} = 2.3 V - 2.7 V | | | | 18 | mA |
| I _{OH} | HIGH Level Output Current, V _{CC} = 1.65 V - 1.95 V | | | | -6 | mA |
| I _{OL} | LOW Level Output Current, V _{CC} = 1.65 V - 1.95 V | | | | 6 | mA |
| T _A | Operating Free–Air Temperature | | -40 | | +85 | °C |
| Δt/ΔV | Input Transition Rise or Fall Rate, V _{IN} from 0.8 V to 2.0 V, V _{CC} = 3.0 V | | 0 | | 10 | ns/V |

DC ELECTRICAL CHARACTERISTICS

| | | | T _A = -40° | C to +85°C | |
|------------------|---------------------------------------|---|------------------------|------------------------|------|
| Symbol | Characteristic | Condition | Min | Max | Unit |
| V _{IH} | HIGH Level Input Voltage (Note 2) | 1.65 V ≤ V _{CC} < 2.3 V | 0.65 x V _{CC} | | V |
| | | 2.3 V ≤ V _{CC} ≤ 2.7 V | 1.6 | | |
| | | 2.7 V < V _{CC} ≤ 3.6 V | 2.0 | | |
| V _{IL} | LOW Level Input Voltage (Note 2) | 1.65 V ≤ V _{CC} < 2.3 V | | 0.35 x V _{CC} | V |
| | | 2.3 V ≤ V _{CC} ≤ 2.7V | | 0.7 | |
| | | 2.7 V < V _{CC} ≤ 3.6 V | | 0.8 | |
| V _{OH} | HIGH Level Output Voltage | $1.65 \text{ V} \le \text{V}_{CC} \le 3.6 \text{ V}; \text{I}_{OH} = -100 \mu\text{A}$ | V _{CC} - 0.2 | | V |
| | | V _{CC} = 1.65 V; I _{OH} = -6 mA | 1.25 | | |
| | | $V_{CC} = 2.3 \text{ V; } I_{OH} = -6 \text{ mA}$ | 2.0 | | |
| | | $V_{CC} = 2.3 \text{ V; } I_{OH} = -12 \text{ mA}$ | 1.8 | | |
| | | $V_{CC} = 2.3 \text{ V; } I_{OH} = -18 \text{ mA}$ | 1.7 | | |
| | | $V_{CC} = 2.7 \text{ V; } I_{OH} = -12 \text{ mA}$ | 2.2 | | |
| | | $V_{CC} = 3.0 \text{ V; } I_{OH} = -18 \text{ mA}$ | 2.4 | | |
| | | $V_{CC} = 3.0 \text{ V; } I_{OH} = -24 \text{ mA}$ | 2.2 | | |
| V_{OL} | LOW Level Output Voltage | $1.65 \text{ V} \le \text{V}_{CC} \le 3.6 \text{ V}; \text{ I}_{OL} = 100 \mu\text{A}$ | | 0.2 | V |
| | | V _{CC} = 1.65 V; I _{OL} = 6 mA | | 0.3 | |
| | | V _{CC} = 2.3 V; I _{OL} = 12 mA | | 0.4 | |
| | | V _{CC} = 2.3 V; I _{OL} = 18 mA | | 0.6 | |
| | | V _{CC} = 2.7 V; I _{OL} = 12 mA | | 0.4 | |
| | | V _{CC} = 3.0 V; I _{OL} = 18 mA | | 0.4 | |
| | | V _{CC} = 3.0 V; I _{OL} = 24 mA | | 0.55 | |
| I _I | Input Leakage Current | $1.65 \text{ V} \le \text{V}_{CC} \le 3.6 \text{ V}; 0 \text{ V} \le \text{V}_{I} \le 3.6 \text{ V}$ | | ±5.0 | μΑ |
| I _{OZ} | 3-State Output Current | $1.65 \text{ V} \le \text{V}_{CC} \le 3.6 \text{ V}; 0 \text{ V} \le \text{V}_{O} \le 3.6 \text{ V};$ $\text{V}_{I} = \text{V}_{IH} \text{ or V}_{IL}$ | | ±10 | μΑ |
| l _{OFF} | Power-Off Leakage Current | V _{CC} = 0 V; V _I or V _O = 3.6 V | | 10 | μΑ |
| I _{CC} | Quiescent Supply Current (Note 3) | $1.65 \text{ V} \le \text{V}_{CC} \le 3.6 \text{ V}; \text{ V}_{I} = \text{GND or V}_{CC}$ | | 20 | μΑ |
| | | $1.65 \text{ V} \le \text{V}_{CC} \le 3.6 \text{ V}; 3.6 \text{ V} \le \text{V}_{I}, \text{V}_{O} \le 3.6 \text{ V}$ | | ±20 | μΑ |
| ΔI_{CC} | Increase in I _{CC} per Input | $2.7 \text{ V} < \text{V}_{CC} \le 3.6 \text{ V}; \text{V}_{IH} = \text{V}_{CC} - 0.6 \text{ V}$ | | 750 | μΑ |
| | | | | | |

These values of V_I are used to test DC electrical characteristics only.
 Outputs disabled or 3-state only.

AC CHARACTERISTICS (Note 4; $t_R = t_F = 2.0 \text{ ns}$; $C_L = 30 \text{ pF}$; $R_L = 500 \Omega$)

| | | | | | T _A = -40° | C to +85°C | | | |
|--|---|----------|-----------------------|------------|-----------------------|------------|-----------------------|--------------|------|
| | | | V _{CC} = 3.0 | V to 3.6 V | V _{CC} = 2.3 | V to 2.7 V | V _{CC} = 1.6 | 5 to 1.95V | • |
| Symbol | Parameter | Waveform | Min | Max | Min | Max | Min | Max | Unit |
| t _{PLH} t _{PHL} | Propagation Delay Input to Output | 1 | 0.8 0.8 | 2.5 2.5 | 1.0 1.0 | 3.0 3.0 | 1.5 1.5 | 6.0 6.0 | ns |
| t _{PZH} t _{PZL} | Output Enable Time to High and Low Level | 2 | 0.8 0.8 | 3.5 3.5 | 1.0 1.0 | 4.1 4.1 | 1.5 1.5 | 8.2 8.2 | ns |
| t _{PHZ} | Output Disable Time From High and Low Level | 2 | 0.8 0.8 | 3.5 3.5 | 1.0 1.0 | 3.8 3.8 | 1.5 1.5 | 7.8 7.8 | ns |
| t _{OSHL} t _{OSLH} | Output-to-Output Skew (Note 5) | | | 0.5 0.5 | | 0.5 0.5 | | 0.75 0.75 | ns |

AC CHARACTERISTICS ($t_R = t_F = 2.0 \text{ ns}; C_L = 50 \text{ pF}; R_L = 500 \ \Omega$)

| | | | | T _A = −40°C | to +85°C | | |
|--------------------------------------|---|----------|-----------------------|------------------------|-------------------|------------|------|
| | | | V _{CC} = 3.0 | OV to 3.6V | V _{CC} = | = 2.7V | |
| Symbol | Parameter | Waveform | Min | Max | Min | Max | Unit |
| t _{PLH} t _{PHL} | Propagation Delay Input to Output | 3 | 1.0 1.0 | 3.9 3.9 | | 5.3 5.3 | ns |
| t _{PZH} t _{PZL} | Output Enable Time to High and Low Level | 4 | 1.0 1.0 | 5.0 5.0 | | 6.1 6.1 | ns |
| t _{PHZ} t _{PLZ} | Output Disable Time From High and Low Level | 4 | 1.0 1.0 | 4.4 4.4 | | 4.8 4.8 | ns |
| t _{OSHL} | Output-to-Output Skew (Note 6) | | | 0.5 0.5 | | 0.5 0.5 | ns |

^{6.} Skew is defined as the absolute value of the difference between the actual propagation delay for any two separate outputs of the same device. The specification applies to any outputs switching in the same direction, either HIGH-to-LOW (t_{OSHL}) or LOW-to-HIGH (t_{OSLH}); parameter guaranteed by design.

^{4.} For C_L = 50 pF, add approximately 300 ps to the AC maximum specification.
5. Skew is defined as the absolute value of the difference between the actual propagation delay for any two separate outputs of the same device. The specification applies to any outputs switching in the same direction, either HIGH-to-LOW (toSHL) or LOW-to-HIGH (toSLH); parameter guaranteed by design.

DYNAMIC SWITCHING CHARACTERISTICS

| Symbol | Characteristic | Condition | Typical (T _A = +25°C) | Unit |
|------------------|--------------------------------------|--|-------------------------------------|------|
| V _{OLP} | Dynamic LOW Peak Voltage (Note 7) | $V_{CC} = 1.8 \text{ V}, C_L = 30 \text{ pF}, V_{IH} = V_{CC}, V_{IL} = 0 \text{ V}$ | 0.25 | V |
| | | $V_{CC} = 2.5 \text{ V}, C_L = 30 \text{ pF}, V_{IH} = V_{CC}, V_{IL} = 0 \text{ V}$ | 0.6 | |
| | | $V_{CC} = 3.3 \text{ V}, C_L = 30 \text{ pF}, V_{IH} = V_{CC}, V_{IL} = 0 \text{ V}$ | 0.8 | |
| V _{OLV} | Dynamic LOW Valley Voltage (Note 7) | $V_{CC} = 1.8 \text{ V}, C_L = 30 \text{ pF}, V_{IH} = V_{CC}, V_{IL} = 0 \text{ V}$ | -0.25 | V |
| | | $V_{CC} = 2.5 \text{ V}, C_L = 30 \text{ pF}, V_{IH} = V_{CC}, V_{IL} = 0 \text{ V}$ | -0.6 | |
| | | $V_{CC} = 3.3 \text{ V}, C_L = 30 \text{ pF}, V_{IH} = V_{CC}, V_{IL} = 0 \text{ V}$ | -0.8 | |
| V _{OHV} | Dynamic HIGH Valley Voltage (Note 8) | $V_{CC} = 1.8 \text{ V}, C_L = 30 \text{ pF}, V_{IH} = V_{CC}, V_{IL} = 0 \text{ V}$ | 1.5 | V |
| | | $V_{CC} = 2.5 \text{ V}, C_L = 30 \text{ pF}, V_{IH} = V_{CC}, V_{IL} = 0 \text{ V}$ | 1.9 | |
| | | $V_{CC} = 3.3 \text{ V}, C_L = 30 \text{ pF}, V_{IH} = V_{CC}, V_{IL} = 0 \text{ V}$ | 2.2 | |

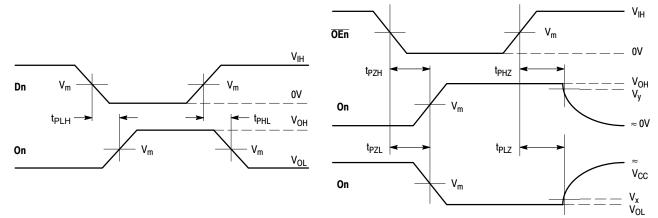
^{7.} Number of outputs defined as "n". Measured with "n-1" outputs switching from HIGH-to-LOW or LOW-to-HIGH. The remaining output is measured in the LOW state.

CAPACITIVE CHARACTERISTICS

| Symbol | Parameter | Condition | Typical | Unit |
|------------------|-------------------------------|----------------|---------|------|
| C _{IN} | Input Capacitance | Note 9 | 6 | pF |
| C _{OUT} | Output Capacitance | Note 9 | 7 | pF |
| C _{PD} | Power Dissipation Capacitance | Note 9, 10 MHz | 20 | pF |

^{9.} $V_{CC} = 1.8 \text{ V}$, 2.5 V or 3.3 V; $V_I = 0 \text{ V or } V_{CC}$.

^{8.} Number of outputs defined as "n". Measured with "n-1" outputs switching from HIGH-to-LOW or LOW-to-HIGH. The remaining output is measured in the HIGH state.



WAVEFORM 1 - PROPAGATION DELAYS

 $t_R = t_F = 2.0 \text{ ns}, 10\% \text{ to } 90\%; f = 1 \text{ MHz}; t_W = 500 \text{ ns}$

WAVEFORM 2 - OUTPUT ENABLE AND DISABLE TIMES

 $t_R = t_F = 2.0 \text{ ns}, 10\% \text{ to } 90\%; f = 1 \text{ MHz}; t_W = 500 \text{ ns}$

Figure 4. AC Waveforms

Table 2. AC WAVEFORMS

| | | V _{CC} | | | | |
|-----------------|-------------------------|--------------------------|--------------------------|--|--|--|
| Symbol | 3.3 V \pm 0.3 V | 2.5 V \pm 0.2 V | 1.8 V ± 0.15 V | | | |
| V _{IH} | 2.7 V | V _{CC} | V _{CC} | | | |
| V _m | 1.5 V | V _{CC} /2 | V _{CC} /2 | | | |
| V _x | V _{OL} + 0.3 V | V _{OL} + 0.15 V | V _{OL} + 0.15 V | | | |
| V_y | V _{OH} – 0.3 V | V _{OH} – 0.15 V | V _{OH} – 0.15 V | | | |

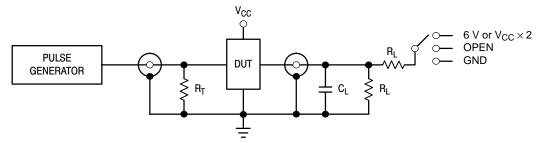


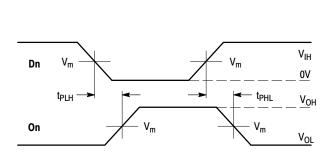
Figure 5. Test Circuit

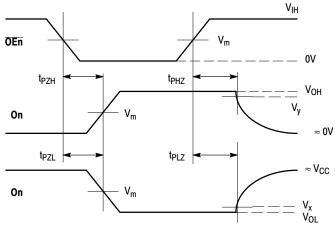
Table 3. TEST CIRCUIT

| TEST | SWITCH |
|-------------------------------------|--|
| t _{PLH} , t _{PHL} | Open |
| t _{PZL} , t _{PLZ} | 6 V at V_{CC} = 3.3 ± 0.3 V; $V_{CC} \times$ 2 at V_{CC} = 2.5 ± 0.2 V; 1.8 ± 0.15 V |
| t _{PZH} , t _{PHZ} | GND |

C_L = 30 pF or equivalent (Includes jig and probe capacitance)

 $R_L = 500 \Omega$ or equivalent $R_T = Z_{OUT}$ of pulse generator (typically 50 Ω)





WAVEFORM 3 - PROPAGATION DELAYS

 $t_R = t_F = 2.0 \text{ ns}$, 10% to 90%; f = 1 MHz; $t_W = 500 \text{ ns}$

WAVEFORM 4 - OUTPUT ENABLE AND DISABLE TIMES

 t_R = t_F = 2.0 ns, 10% to 90%; f = 1 MHz; t_W = 500 ns

Figure 6. AC Waveforms

Table 4. AC WAVEFORMS

| | V _{CC} | | |
|-----------------|-------------------------|-------------------------|--|
| Symbol | 3.3 V \pm 0.3 V | 2.7 V | |
| V _{IH} | 2.7 V | 2.7 V | |
| V _m | 1.5 V | 1.5 V | |
| V _x | V _{OL} + 0.3 V | V _{OL} + 0.3 V | |
| V _y | V _{OH} – 0.3 V | V _{OH} – 0.3 V | |

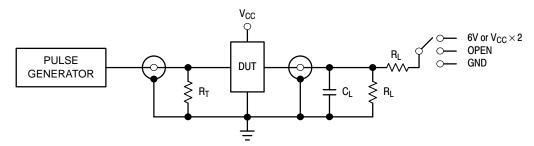


Figure 7. Test Circuit

Table 5. TEST CIRCUIT

| TEST | SWITCH | |
|-------------------------------------|---|--|
| t _{PLH} , t _{PHL} | Open | |
| t _{PZL} , t _{PLZ} | 6 V at V_{CC} = 3.3 ± 0.3 V; $V_{CC} \times$ 2 at V_{CC} = 2.5 ± 0.2 V; 1.8 ± 0.15 V | |
| t _{PZH} , t _{PHZ} | GND | |

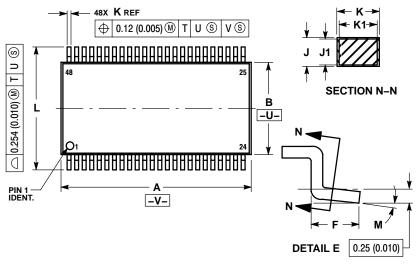
 C_L = 50 pF or equivalent (Includes jig and probe capacitance)

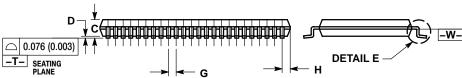
 $R_L = 500 \Omega$ or equivalent $R_T = Z_{OUT}$ of pulse generator (typically 50 Ω)

PACKAGE DIMENSIONS

TSSOP DT SUFFIX CASE 1201-01

ISSUE A





- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: MILLIMETER.
 3. DIMENSIONS A AND B DO NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS. MOLD FLASH OR GATE BURRS SHALL NOT EXCEED 0.15 (0.006) PER SIDE.
 4. DIMENSION K DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.08 (0.003) TOTAL IN EXCESS OF THE K DIMENSION AT MAXIMUM MATERIAL CONDITION.
 5. TERMINAL NUMBERS ARE SHOWN FOR
- MAIEHIAL CONDITION.

 5. TERMINAL NUMBERS ARE SHOWN FOR REFERENCE ONLY.

 6. DIMENSIONS A AND B ARE TO BE DETERMINED AT DATUM PLANE -W-.

| | MILLIMETERS | | INCHES | |
|------------|-------------|-------|------------|-------|
| DIM | MIN | MAX | MIN | MAX |
| Α | 12.40 | 12.60 | 0.488 | 0.496 |
| В | 6.00 | 6.20 | 0.236 | 0.244 |
| C | | 1.10 | | 0.043 |
| D | 0.05 | 0.15 | 0.002 | 0.006 |
| F | 0.50 | 0.75 | 0.020 | 0.030 |
| G | 0.50 BSC | | 0.0197 BSC | |
| Н | 0.37 | | 0.015 | |
| J | 0.09 | 0.20 | 0.004 | 0.008 |
| J1 | 0.09 | 0.16 | 0.004 | 0.006 |
| Κ | 0.17 | 0.27 | 0.007 | 0.011 |
| K 1 | 0.17 | 0.23 | 0.007 | 0.009 |
| Г | 7.95 | 8.25 | 0.313 | 0.325 |
| M | 0 ° | 8 ° | 0 ° | 8 ° |

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